

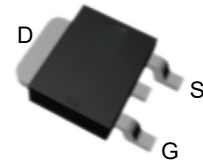
Features

- 80V/80A*
 $R_{DS(ON)}=5.5\text{m}\Omega(\text{typ.})@V_{GS}=10\text{V}$
- 100% UIS + R_g Tested
- Reliable and Rugged
- Lead Free and Green Devices Available
(RoHS Compliant)
- Moisture Sensitivity Level MSL1
(per JEDEC J-STD-020D)

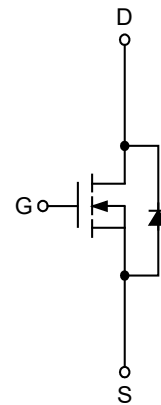
Applications

- Power Management for SMPS synchronous rectification.
- Mobile USB-PD and quick charge adaptor.

Pin Description



TO-252-2



N-Channel MOSFET

Absolute Maximum Ratings ($T_A=25^{\circ}\text{C}$ Unless Otherwise Noted)

		Rating		Unit
Symbol	Parameter			
Common Ratings		80		V
V_{DSS}	Drain-Source Voltage	± 20		
V_{GSS}	Gate-Source Voltage	150		$^{\circ}\text{C}$
T_J	Maximum Junction Temperature	-55 to 150		
T_{STG}	Storage Temperature Range	$T_C=25^{\circ}\text{C}$	50	A
I_S	Diode Continuous Forward Current	$T_C=25^{\circ}\text{C}$	80^*	A
I_D	Continuous Drain Current	$T_C=100^{\circ}\text{C}$	63	
		$T_C=25^{\circ}\text{C}$	300^a	
I_{DM}	Pulsed Drain Current	$T_C=25^{\circ}\text{C}$	104	W
P_D	Maximum Power Dissipation	$T_C=100^{\circ}\text{C}$	41.6	
		Steady State	1.2	$^{\circ}\text{C}/\text{W}$
$R_{\theta JC}$	Thermal Resistance-Junction to Case	$T_A=25^{\circ}\text{C}$	15.4	A
I_D	Continuous Drain Current	$T_A=70^{\circ}\text{C}$	12.3	
		$T_A=25^{\circ}\text{C}$	2.5	W
P_D	Maximum Power Dissipation	$T_A=70^{\circ}\text{C}$	1.6	
		Steady State	50	$^{\circ}\text{C}/\text{W}$
$R_{\theta JA}^b$	Thermal Resistance-Junction to Ambient	$L=0.5\text{mH}$	29	A
I_{AS}^c	Avalanche Current, Single pulse	$L=0.5\text{mH}$	210	mJ
E_{AS}^c	Avalanche Energy, Single pulse			

Note * : Current limited by bonding wire.

Note a : Pulse width limited by maximum junction temperature.

$T_J=25^{\circ}\text{C}$).

Note b : Surface mounted on 1in^2 pad area.

Note c : UIS tested and pulse width limited by maximum junction temperature (initial temperature

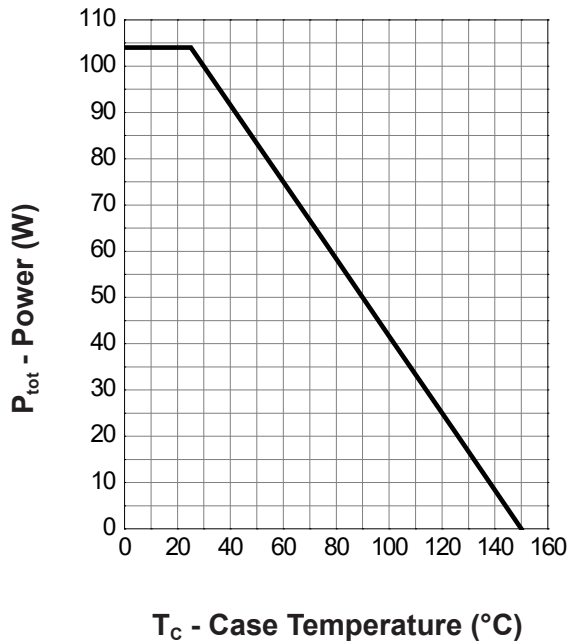
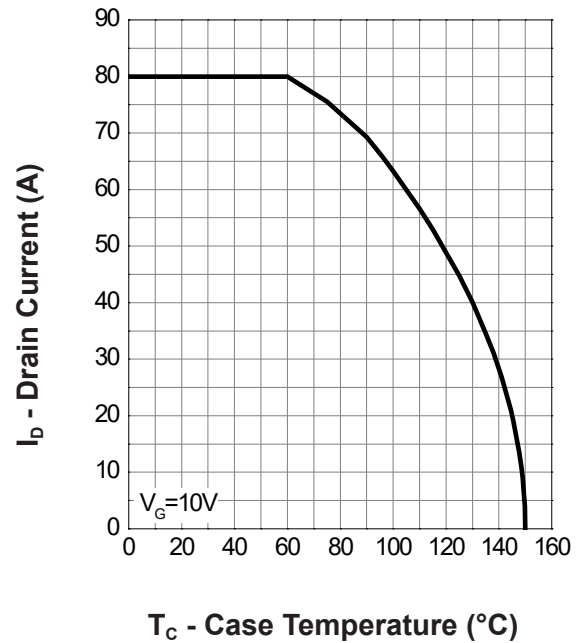
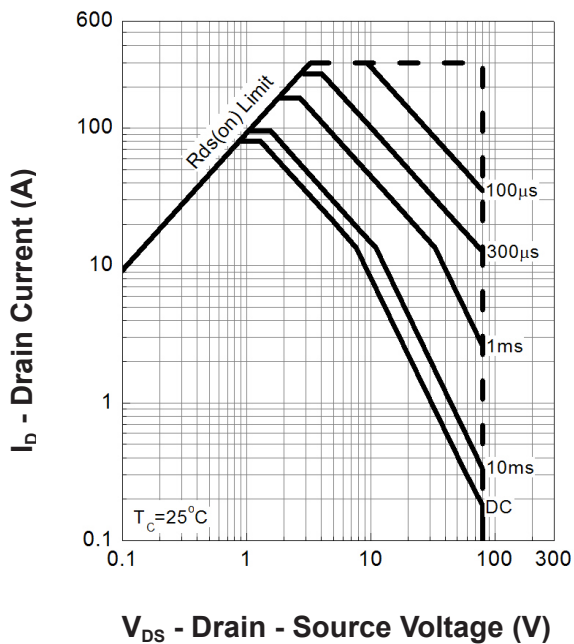
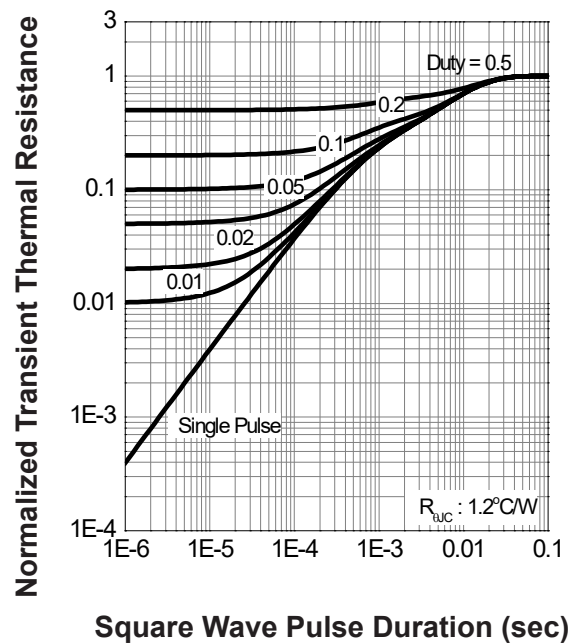
Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =250μA	80	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =64V, V _{GS} =0V	-	-	1	μA
		T _J =85°C	-	-	30	
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250μA	2	3	4	V
I _{GSS}	Gate Leakage Current	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA
R _{DS(ON)} ^d	Drain-Source On-state Resistance	V _{GS} =10V, I _{DS} =40A	-	5.5	6.7	mΩ
Diode Characteristics						
V _{SD} ^d	Diode Forward Voltage	I _{SD} =20A, V _{GS} =0V	-	0.8	1.3	V
t _{rr}	Reverse Recovery Time	I _{SD} =40A, dI _{SD} /dt=100A/μs	-	46	-	ns
Q _{rr}	Reverse Recovery Charge		-	65	-	nC
Dynamic Characteristics ^e						
R _G	Gate Resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz	-	1	-	Ω
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =40V, Frequency=1.0MHz	-	2120	2680	pF
C _{oss}	Output Capacitance		-	240	-	
C _{rss}	Reverse Transfer Capacitance		-	50	-	
t _{d(ON)}	Turn-on Delay Time	V _{DD} =30V, R _L =30Ω, I _{DS} =1A, V _{GEN} =10V, R _G =6Ω	-	21	38	ns
t _r	Turn-on Rise Time		-	9	16	
t _{d(OFF)}	Turn-off Delay Time		-	72	130	
t _f	Turn-off Fall Time		-	67	121	
Gate Charge Characteristics ^e						
Q _g	Total Gate Charge	V _{DS} =40V, V _{GS} =4.5V, I _{DS} =40A	-	28	-	nC
Q _g	Total Gate Charge	V _{DS} =40V, V _{GS} =10V, I _{DS} =40A	-	62	87	
Q _{gs}	Gate-Source Charge		-	14.4	-	
Q _{gd}	Gate-Drain Charge		-	8.4	-	

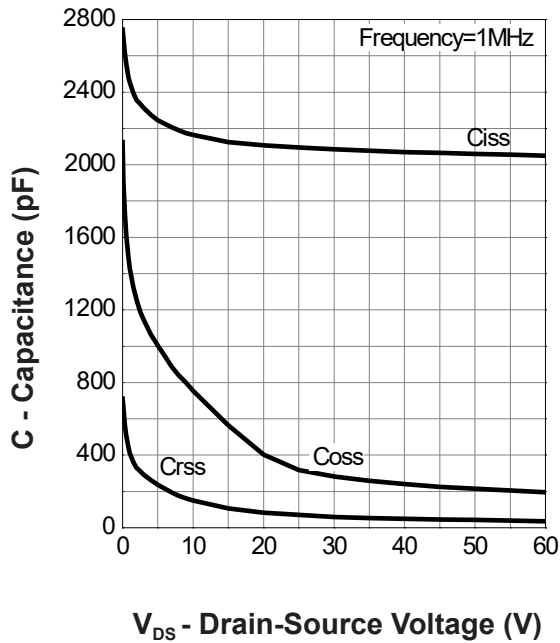
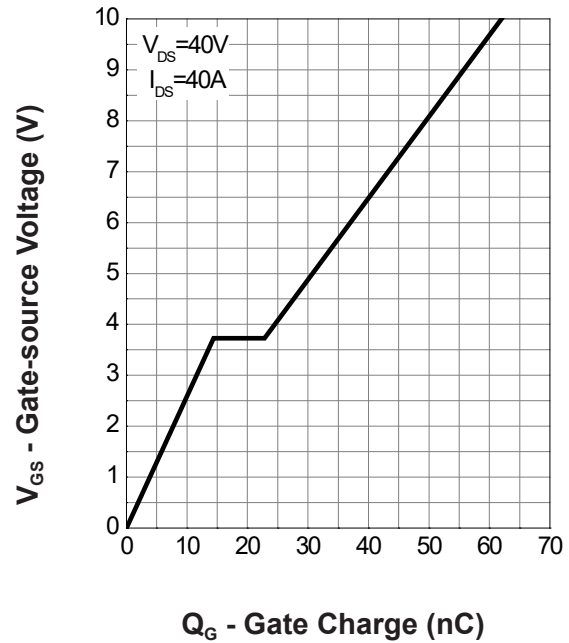
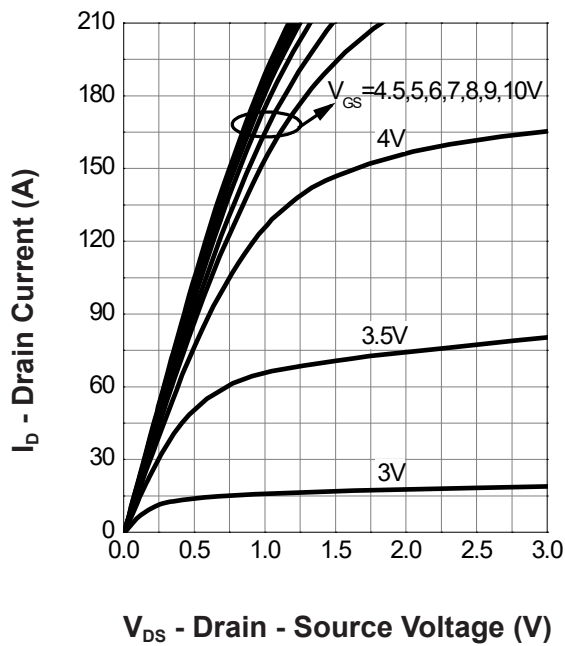
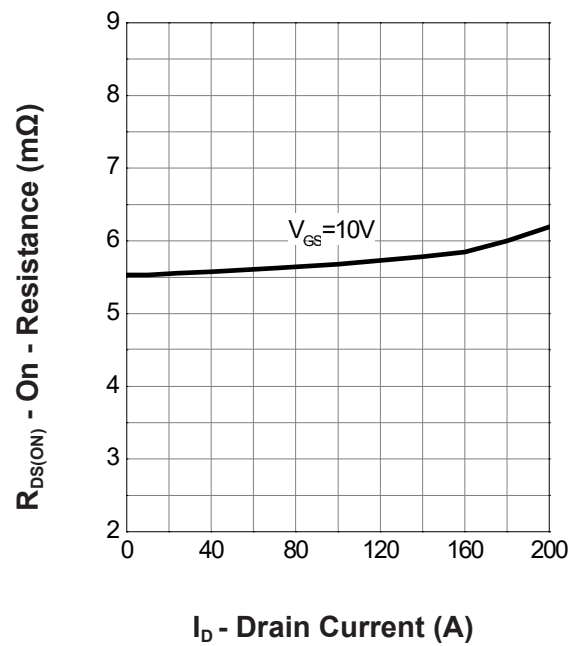
Note d : Pulse test ; pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.

Note e : Guaranteed by design, not subject to production testing.

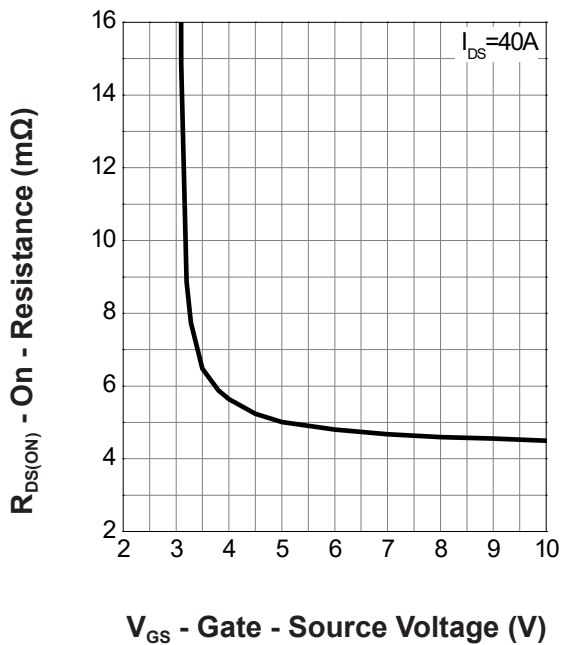
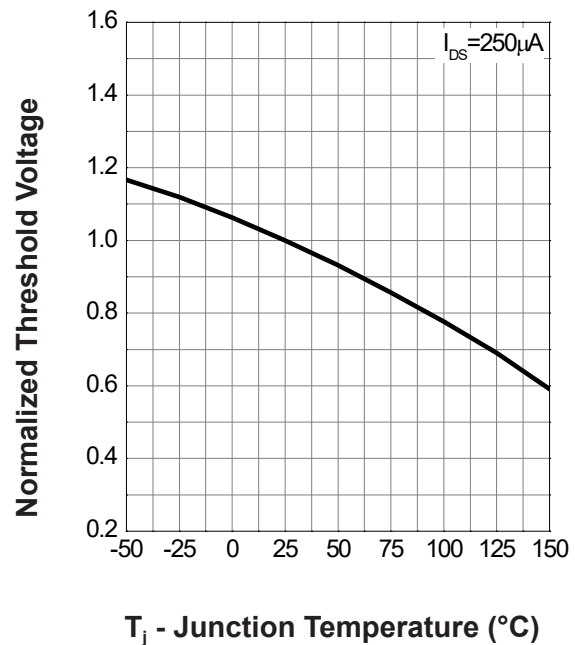
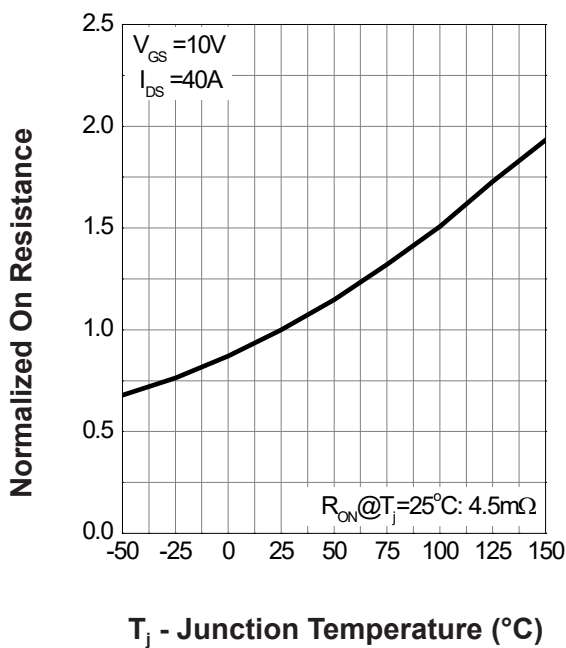
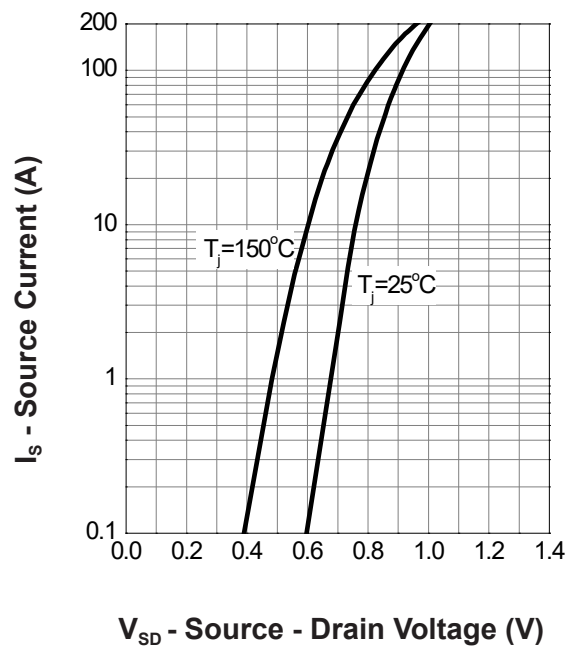
Typical Operating Characteristics

Power Dissipation

Drain Current

Safe Operation Area

Thermal Transient Impedance


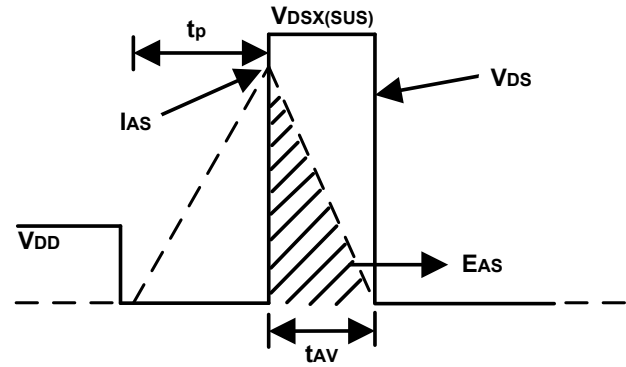
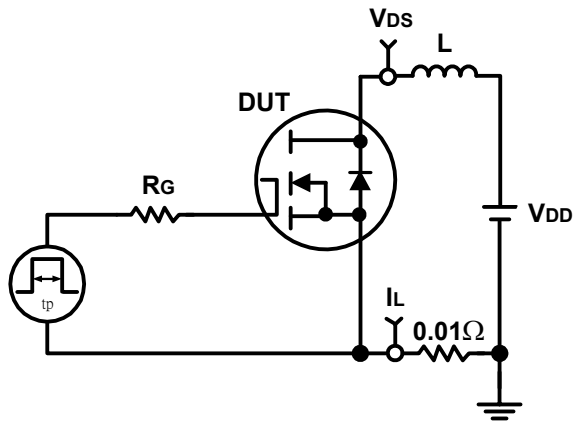
Typical Operating Characteristics(Cont.)

Capacitance

Gate Charge

Output Characteristics

Drain-Source On Resistance


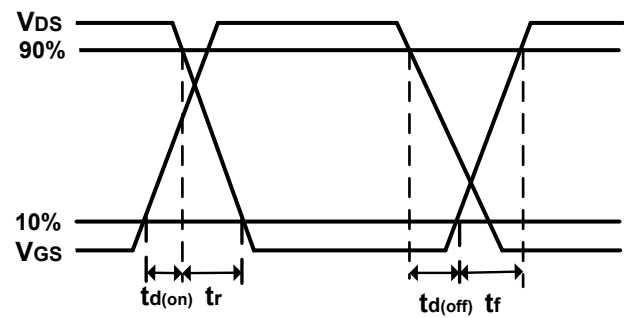
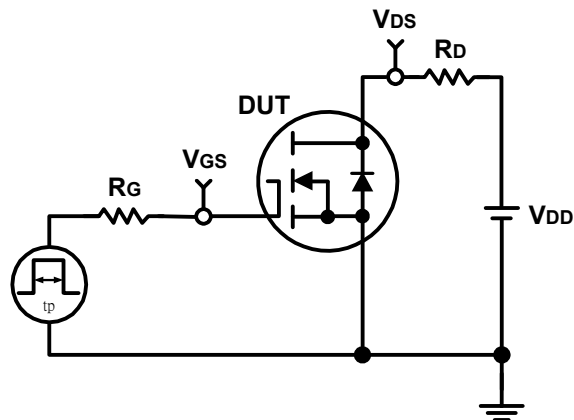
Typical Operating Characteristics(Cont.)

Gate-Source On Resistance

Gate Threshold Voltage

Drain-Source On Resistance

Source-Drain Diode Forward


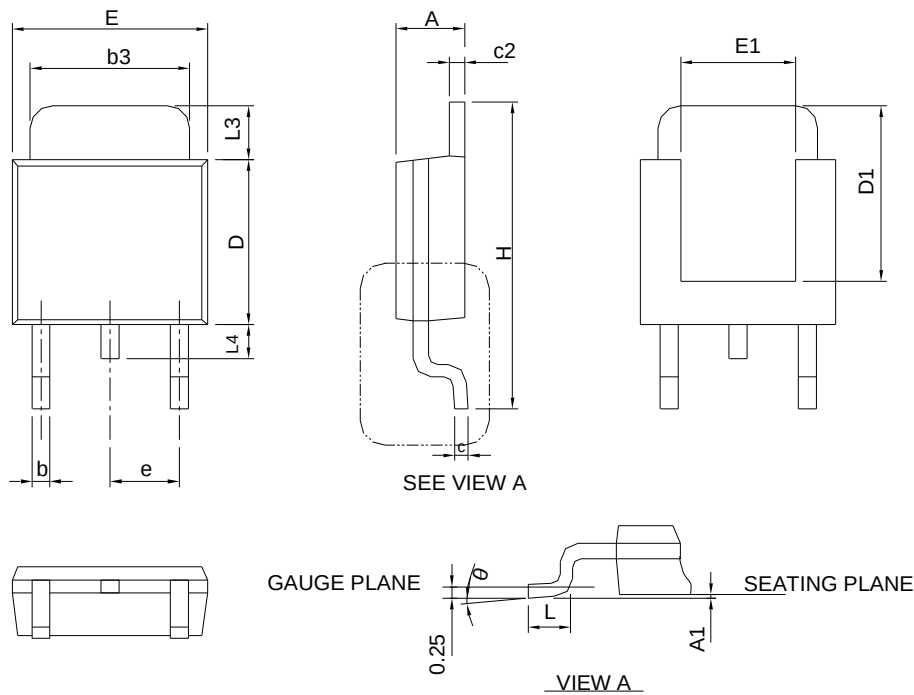
Avalanche Test Circuit and Waveforms



Switching Time Test Circuit and Waveforms



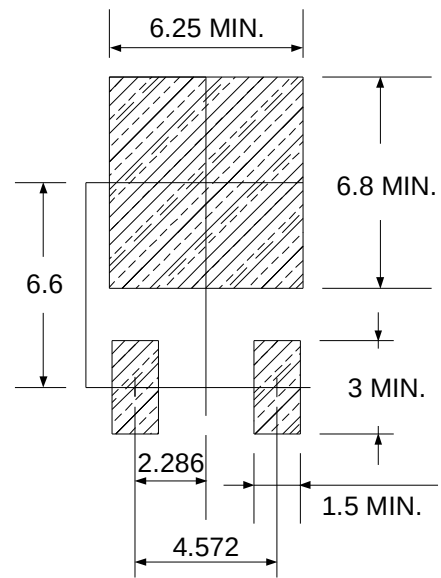
Package Information



DIMENSIONS	TO-252-2			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	2.18	2.39	0.086	0.094
A1	-	0.13	-	0.005
b	0.50	0.89	0.020	0.035
b3	4.95	5.46	0.195	0.215
c	0.46	0.61	0.018	0.024
c2	0.46	0.89	0.018	0.035
D	5.33	6.22	0.210	0.245
D1	4.57	6.00	0.180	0.236
E	6.35	6.73	0.250	0.265
E1	3.81	6.00	0.150	0.236
e	2.29 BSC		0.090 BSC	
H	9.40	10.41	0.370	0.410
L	0.90	1.78	0.035	0.070
L3	0.89	2.03	0.035	0.080
L4	-	1.02	-	0.040
θ	0°	8°	0°	8°

Note : Follow JEDEC TO-252-2

RECOMMENDED LAND PATTERN



UNIT: mm